Search Notes		

Applica	tion/Control No.	Applicant(s)/Patent under Reexamination	
10/518	487	TANAKA ET AL.	
Examin	er	Art Unit	
Sue A.	Weaver	3781	

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Class	Subclass	Date	Examiner
215	379-383		
220	669,672,		
	675	6/6/2007	-5w
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INT	INTERFERENCE SEARCHED		
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